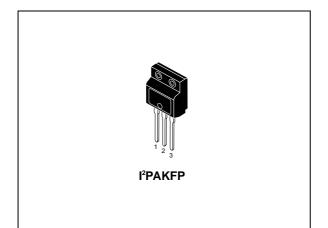
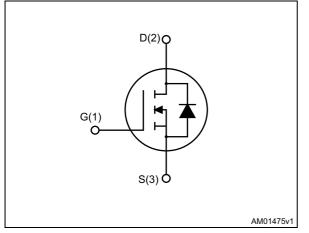


# STFI34NM60N

## N-channel 600 V, 0.092 Ω, 31.5 A MDmesh<sup>™</sup> II Power MOSFET in a I<sup>2</sup>PAKFP package Datasheet - production data



### Figure 1. Internal schematic diagram



### Features

Order code	$V_{\text{DSS}}$	R <sub>DS(on)</sub>	I <sub>D</sub>	P <sub>TOT</sub>
STFI34NM60N	600 V	0.105 Ω	31.5 A	40 W

- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance

### **Applications**

• Switching applications

### Description

This device is an N-channel Power MOSFET developed using the second generation of MDmesh<sup>™</sup> technology. This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

#### Table 1. Device summary

Order code	Marking	Packages	Packaging
STFI34NM60N	34NM60N	I <sup>2</sup> PAKFP (TO-281)	Tube

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This is information on a product in full production.

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### 1

## **Electrical ratings**

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage	600	V
V <sub>GS</sub>	Gate-source voltage	± 25	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	31.5 <sup>(1)</sup>	А
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	20 <sup>(1)</sup>	А
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	126	Α
P <sub>TOT</sub>	Total dissipation at $T_C = 25 \text{ °C}$	40	W
I <sub>AR</sub>	Max current during repetitive or single pulse		А
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}$ , $I_D = I_{AS}$ , $V_{DD} = 50 \text{ V}$ )	345	mJ
V <sub>ISO</sub> Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s;T <sub>C</sub> =25 °C)		2500	V
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	15	V/ns
dv/dt <sup>(4)</sup> MOSFET dv/dt ruggedness		50	V/ns
T <sub>stg</sub>	Storage temperature	-55 to 150	°C
T <sub>j</sub> Operating junction temperature		150	

Table 2.	Absolute	maximum	ratings
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1. Limited by package.

2. Pulse width limited by safe operating area.

3. I\_{SD}~\leq 31.5 A, di/dt  $\leq$  400 A/µs, V\_{DS} peak  $\leq$  V\_{(BR)DSS}, V\_{DD} = 80% V\_{(BR)DSS}

4.  $V_{DS} \leq 480 \text{ V}$ 

#### Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	3.1	°C/W
R <sub>thj-amb</sub> Thermal resistance junction-amb max		62.5	0/00



## 2 Electrical characteristics

 $(T_{CASE} = 25 \text{ °C unless otherwise specified}).$ 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage (V <sub>GS</sub> = 0)	I <sub>D</sub> = 1 mA	600			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 600 V V <sub>DS</sub> = 600 V, Tc=125 °C			1 100	μΑ μΑ
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 25 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2	3	4	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 14.5 A		0.092	0.105	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	2722	-	pF
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> =100 V, f=1 MHz, V <sub>GS</sub> =0	-	173	-	pF
C <sub>rss</sub>	Reverse transfer capacitance		-	1.75	-	pF
C <sub>oss eq.</sub> <sup>(1)</sup>	Equivalent capacitance time related	$V_{GS} = 0, V_{DS} = 0$ to 480 V	-	458	-	pF
t <sub>d(on)</sub>	Turn-on delay time		-	18	-	ns
t <sub>r</sub>	Rise time	V <sub>DD</sub> = 300 V, I <sub>D</sub> = 15.75 A, R <sub>G</sub> =4.7 Ω, V <sub>GS</sub> =10 V	-	36	-	ns
t <sub>d(off)</sub>	Turn-off delay time	(see Figure 18 and 14)	-	104	-	ns
t <sub>f</sub>	Fall time		-	73	-	ns
Qg	Total gate charge	V <sub>DD</sub> = 480 V, I <sub>D</sub> = 31.5 A	-	84	-	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> =10 V	-	14	-	nC
Q <sub>gd</sub>	Gate-drain charge	(see Figure 15)	-	45	-	nC
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz, gate DC Bias=0 test signal level=20 mV open drain	-	2.9	-	Ω

1.  $C_{oss eq}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		31.5	А
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		126	А
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	prward on voltage $I_{SD}$ = 31.5 A, V <sub>GS</sub> =0			1.6	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 31.5 A, V <sub>DD</sub> = 60 V	-	412		ns
Q <sub>rr</sub>	Reverse recovery charge	di/dt = 100 A/µs,	-	8		nC
I <sub>RRM</sub>	Reverse recovery current	(see Figure 16)	-	39		А
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 12 A,V <sub>DD</sub> = 60 V	-	490		ns
Q <sub>rr</sub>	Reverse recovery charge	di/dt=100 A/µs, T <sub>i</sub> =150 °C	-	10		nC
I <sub>RRM</sub>	Reverse recovery current	(see Figure 16)	-	43		А

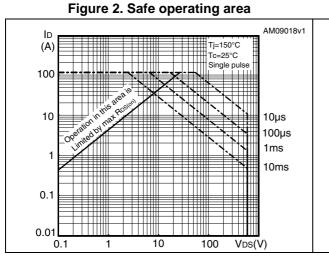
Table 6. Source drain diode

1. Pulse width limited by safe operating area

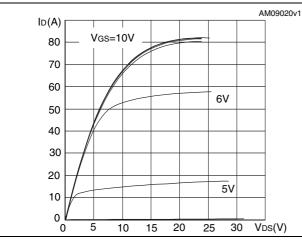
2. Pulsed: Pulse duration =  $300 \ \mu$ s, duty cycle 1.5%.



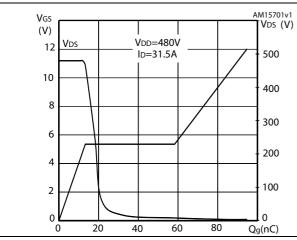
## 2.1 Electrical characteristics (curves)



### Figure 4. Output characteristics



#### Figure 6. Gate charge vs gate-source voltage



### Figure 3. Thermal impedance

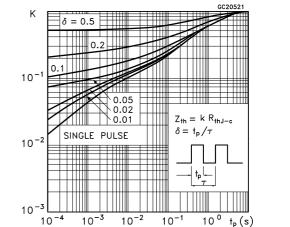
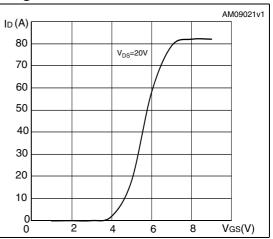
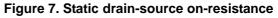
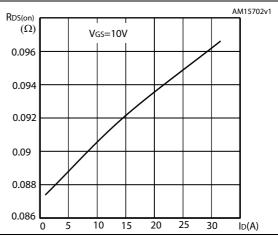


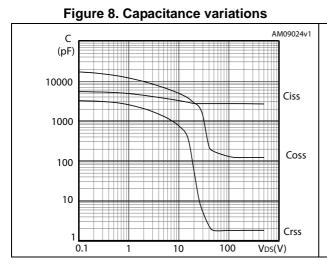
Figure 5. Transfer characteristics

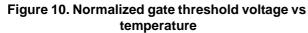












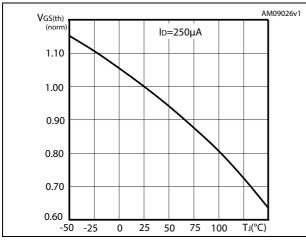
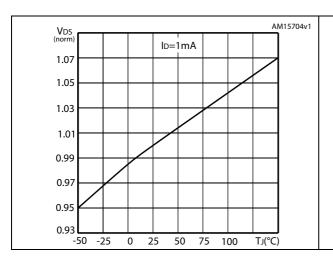


Figure 12. Normalized  $\mathsf{B}_{\mathsf{VDSS}}$  vs temperature



Electrical characteristics

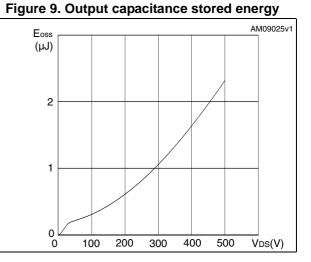


Figure 11. Normalized on-resistance vs temperature

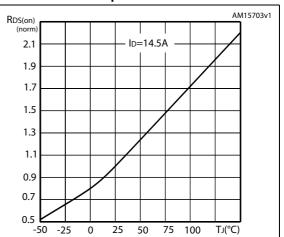
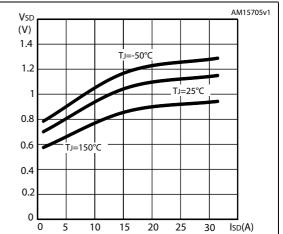


Figure 13. Source-drain diode forward characteristics





#### 3 **Test circuits**

Figure 14. Switching times test circuit for resistive load

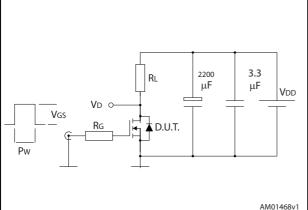


Figure 16. Test circuit for inductive load switching and diode recovery times

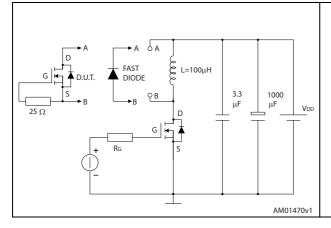


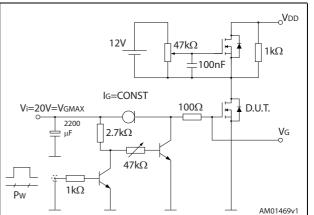
Figure 18. Unclamped inductive waveform

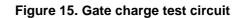
VD

ldм

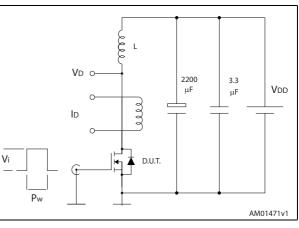
lр

V(BR)DSS









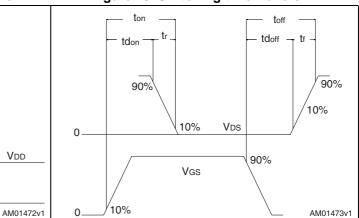


Figure 19. Switching time waveform



Vdd



Vdd

## 4 Package mechanical data

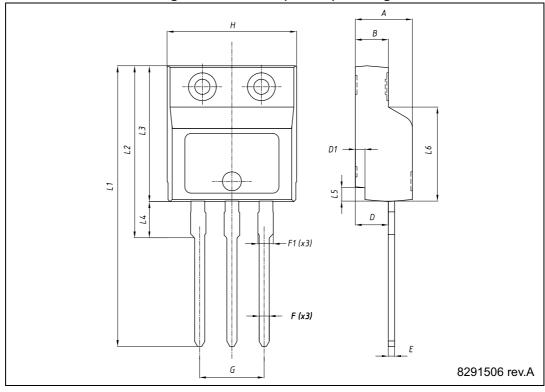
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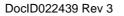


Dim		mm	
Dim.	Min.	Тур.	Max.
А	4.40		4.60
В	2.50		2.70
D	2.50		2.75
D1	0.65		0.85
E	0.45		0.70
F	0.75		1.00
F1			1.20
G	4.95	-	5.20
Н	10.00		10.40
L1	21.00		23.00
L2	13.20		14.10
L3	10.55		10.85
L4	2.70		3.20
L5	0.85		1.25
L6	7.30		7.50

Table 7. I<sup>2</sup>PAKFP (TO-281) mechanical data

### Figure 20. I<sup>2</sup>PAKFP (TO-281) drawing





## 5 Revision history

Date	Revision	Changes
07-Nov-2011	1	First release.
19-Apr-2012	2	<ul> <li>Units in <i>Table 6</i>: Source drain diode have been corrected.</li> <li><i>Figure 6</i>: Gate charge vs. gate-source voltage has been</li> <li>updated.</li> <li>Minor text changes.</li> </ul>
16-Jul-2013	3	<ul> <li>Modified: title, I<sub>D</sub> and <i>Figure 1</i> in cover page</li> <li>Modified: I<sub>D</sub> for T<sub>C</sub>=20 °C and for T<sub>C</sub>=100 °C, I<sub>DM</sub> in <i>Table 2</i>, note 1, note 3 in <i>Table 2</i></li> <li>Inserted: dv and dt in <i>Table 2</i> and note 4 in <i>Table 2</i></li> <li>Modified: I<sub>SD</sub>, I<sub>SDM</sub> max values in <i>Table 6</i> and <i>Figure 14</i>, 15, 16 and 17</li> </ul>



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